

# DS96F172C/DS96F172M/DS96F174C/DS96F174M EIA-485/EIA-422 Quad Differential Drivers

### **General Description**

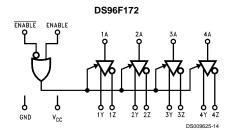
The DS96F172 and the DS96F174 are high speed guad differential line drivers designed to meet EIA-485 Standards. The DS96F172 and the DS96F174 offer improved performance due to the use of L-FAST bipolar technology. The use of LFAST technology allows the DS96F172 and DS96F174 to operate at higher speeds while minimizing power consumption.

The DS96F172 and the DS96F174 have TRI-STATE® outputs and are optimized for balanced multipoint data bus transmission at rates up to 15 Mbps. The drivers have wide positive and negative common mode range for multipoint applications in noisy environments. Positive and negative current-limiting is provided which protects the drivers from line fault conditions over a +12V to -7.0V common mode range. A thermal shutdown feature is also provided. The DS96F172 features an active high and active low Enable. common to all four drivers. The DS96F174 features separate active high Enables for each driver pair.

### **Features**

- Meets EIA-485 and EIA-422 standards
- Monotonic differential output switching
- TRI-STATE outputs
- Designed for multipoint bus transmission
- Common mode output voltage range: -7.0V to +12V
- Operates from single +5.0V supply
- Reduced power consumption
- Thermal shutdown protection
- DS96F172 and DS96F174 are lead and function compatible with the SN75172/174 or the AM26LS31/MC3487
- Military temperature range available
- Qualified for MIL-STD-883C
- Standard military drawings available (SMD)
- Available in DIP (J), LCC (E), and Flatpak (W) packages

### **Logic Diagrams**



# DS96F174 DS009625-15

### Function Tables (Each Driver)

#### DS96F172

Input	Enable		Outputs		
Α	E	Ē	Y	Z	
Н	Н	Х	Н	L	
L	Н	Х	L	Н	
Н	Х	L	Н	L	
L	Х	L	L	Н	
Х	L	Н	Z	Z	

### DS96F174

Input	Enable	Outputs		
Α	E	Y	Z	
Н	Н	Н	L	
L	Н	L	Н	
X	L	Z	Z	

- H = High Level L = Low Level
- X = Don't Care
- Z = High Impedance (Off)

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### **COMMERCIAL**

### **Absolute Maximum Ratings** (Note 2)

Specifications for the 883 version of this product are listed separately on the following pages.

Storage Temperature Range ( $T_{\rm STG}$ ) -65°C to +175°C Lead Temperature (Soldering, 60 sec.) Maximum Package Power Dissipation (Note 1) at 25°C Ceramic DIP (J) 1500 mW Supply Voltage 7.0V Enable Input Voltage 5.5V

### **Recommended Operating Conditions**

	Min	Тур	Max	Units
Supply Voltage (V <sub>CC</sub> )				
DS96F172C/DS96F174C	4.75	5.0	5.25	V
Common Mode	-7.0		+12.0	V
Output Voltage (V <sub>OC</sub> )				
Output Current HIGH (I <sub>OH</sub> )			-60	mA
Output Current LOW (I <sub>OL</sub> )			60	mA
Operating Temperature (T <sub>A</sub> )				
DS96F172C/DS96F174C	0		+70	°C
Note 1: Derate "I" package 10 mW	C above	25°C		

#### Note 1: Derate "J" package 10 mW/°C above 25°C.

### **Electrical Characteristics** (Notes 3, 4)

Over recommended supply voltage and operating temperature range, unless otherwise specified

Symbol	Parameter	Conditions		Min	Typ (Note 2)	Max	Units
V <sub>IH</sub>	Input Voltage HIGH			2.0			V
V <sub>IL</sub>	Input Voltage LOW		$T_A = 0^{\circ}C \text{ to } +70^{\circ}C$			0.8	V
			$T_A = -55^{\circ}C \text{ to } +125^{\circ}C$			0.7	1
V <sub>OH</sub>	Output Voltage HIGH	I <sub>OH</sub> = -33 mA	$T_A = 0^{\circ}C \text{ to } +70^{\circ}C$	3.0			V
V <sub>OL</sub>	Output Voltage LOW	I <sub>OL</sub> = 33 mA	$T_A = 0^{\circ}C \text{ to } +70^{\circ}C$			2.0	V
V <sub>IC</sub>	Input Clamp Voltage	I <sub>I</sub> = -18 mA				-1.5	V
V <sub>OD1</sub>	Differential Output Voltage	$I_O = 0 \text{ mA}$				6.0	V
V <sub>OD2</sub>	Differential Output Voltage	$R_L = 54\Omega$ , Figure 1	$T_A = -55^{\circ}C$	1.2	2.0		V
				1.5			
		$R_L = 100\Omega$ , Figure 1		2.0	2.3		1
V <sub>OD</sub>	Differential Output Voltage	Figure 2	$T_A = 0^{\circ}C \text{ to } +70^{\circ}C$	1.0			V
$\Delta  V_{OD} $	Change in Magnitude of Differential	$R_L = 54\Omega$ or $100\Omega$ ,	-40°C to +125°C			±0.2	V
	Output Voltage (Note 5)	Figure 1	-55°C to +125°C			±0.4	V
V <sub>oc</sub>	Common Mode Output Voltage (Note 6)	$R_L = 54\Omega$ or $100\Omega$ , Figure 1				3.0	V
$\Delta  V_{OC} $	Change in Magnitude of Common	$R_L = 54\Omega$ or $100\Omega$ , Fig.	gure 1			±0.2	V
	Mode Output Voltage (Note 5)						
Io	Output Current with Power Off	$V_{CC} = 0V, V_{O} = -7.0V$	to +12V			±50	μA
l <sub>oz</sub>	High Impedance State Output Current	$V_{\rm O} = -7.0 \text{V to } +12 \text{V}$			±20	±50	μA
I <sub>IH</sub>	Input Current HIGH	V <sub>I</sub> = 2.4V				20	μA
I <sub>IL</sub>	Input Current LOW	V <sub>I</sub> = 0.4V				-50	μA
Ios	Short Circuit Output Current	V <sub>O</sub> = -7.0V				-250	
	(Note 7)	V <sub>O</sub> = 0V				-150	mA
		$V_O = V_{CC}$				150	1
		V <sub>O</sub> = +12V				250	1
I <sub>cc</sub>	Supply Current (All Drivers)	No Load	Outputs Enabled			50	mA
I <sub>ccx</sub>	1		Outputs Disabled			30	1

### **COMMERCIAL**

# **Switching Characteristics**

 $V_{CC} = 5.0V, T_A = 25^{\circ}C$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t <sub>DD</sub>	Differential Output Delay Time	$R_L = 60\Omega$ , Figure 3		15	20	ns
t <sub>TD</sub>	Differential Output Transition Time			15	22	ns
t <sub>PLH</sub>	Propagation Delay Time,	$R_L = 27\Omega$ , Figure 4		12	16	ns
	Low-to-High Level Output					
t <sub>PHL</sub>	Propagation Delay Time,			12	16	ns
	High-to-Low Level Output					
t <sub>ZH</sub>	Output Enable Time to High Level	$R_L = 110\Omega$ , Flgure 4		25	32	ns
t <sub>ZL</sub>	Output Enable Time to Low Level	$R_L = 110\Omega$ , Figure 6		25	32	ns
t <sub>HZ</sub>	Output Disable Time from High Level	$R_L = 110\Omega$ , Figure 5		25	30	ns
t <sub>LZ</sub>	Output Disable Time from Low Level	$R_L = 110\Omega$ , Figure 6		20	25	ns
t <sub>LZL</sub>	Output Disable Time from Low Level	Figure 6		300		ns
	with Load Resistor to GND (Note 8)					
t <sub>SKEW</sub>	Driver Output to Output	$R_L = 60\Omega$		1.0	4.0	ns

Note 2: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. They are not meant to imply that the devices should be operated at these limits. The tables of "Electrical Characteristics" provide conditions for actual device operation.

Note 3: Unless otherwise specified min/max limits apply across the 0°C to +70°C range for the DS96F172C/DS96F174C. All typicals are given for V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C.

Note 4: All currents into the device pins are positive; all currents out of the device pins are negative. All voltages are reference to ground unless otherwise specified.

Note 5:  $\Delta |V_{OD}|$  and  $\Delta |V_{OC}|$  are the changes in magnitude of  $V_{OD}$  and  $V_{OC}$  respectively, that occur when the input is changed from a high level to a low level.

Note 6: In EIA-422A and EIA-485 standards, VOC, which is the average of the two output voltages with respect to ground, is called output offset voltage, VOS.

Note 7: Only one output at a time should be shorted.

Note 8: For more information see Application Bulletin, contact Product Marketing.

Order Number: DS96F172CN

DS96F174CJ

DS96F174CN

NS Package Number J16A or N16E

### MIL-STD-883C

### **Absolute Maximum Ratings** (Note 2)

For complete Military Specifications, refer to the appropriate SMD or MDS.

Storage Temperature Range (T <sub>STG</sub> )	-65°C to +175°C
Lead Temperature (Soldering, 60 sec.)	300°C
Maximum Package Power Dissipation (No	ote 9) at 25°C
Ceramic LCC (E)	2000 mW
Ceramic DIP (J)	1800 mW
Ceramic Flatpak (W)	1000 mW
Supply Voltage	7.0V
Enable Input Voltage	5.5V

# Recommended Operating Conditions

	Min	Тур	Max	Units
Supply Voltage (V <sub>CC</sub> )				
DS96F172M/DS96F174M	4.50	5.0	5.50	V
Common Mode	-7.0		+12.0	V
Output Voltage (V <sub>OC</sub> )				
Output Current HIGH (I <sub>OH</sub> )			-60	mA
Output Current LOW (I <sub>OL</sub> )			60	mA
Operating Temperature (T <sub>A</sub> )				
DS96F172M/DS96F174M	-55		+125	

Note 9: Above  $T_A$  = 25°C, derate "E" package 13.4, "J" package 12.5, "W" package 7.1 mW/C

### **Electrical Characteristics** (Notes 3, 4)

Over recommended supply voltage and operating temperature range unless otherwise specified

Symbol	Parameter	Conditions			Max	Units
V <sub>IH</sub>	Input Voltage HIGH			2.0		V
V <sub>IL</sub>	Input Voltage LOW		$T_A = 25^{\circ}C$		0.8	V
			$T_A = -55^{\circ}C$ , or +125°C		0.7	
V <sub>IC</sub>	Input Clamp Voltage	I <sub>I</sub> = -18 mA			-1.5	V
V <sub>OD1</sub>	Differential Output Voltage	I <sub>O</sub> = 0 mA			6.0	V
V <sub>OD2</sub>	Differential Output Voltage	$R_L = 54\Omega$ , $V_{CC} = 4.5V$	$T_A = -55^{\circ}C$	1.2		
		Figure 1	$T_A = 25^{\circ}C$ , or +125 $^{\circ}C$	1.5		V
		$R_L = 100\Omega, V_{CC} = 4.5V,$	Figure 1	2.0		
$\Delta  V_{OD} $	Change in Magnitude of Differential	$R_L = 54\Omega$ or $100\Omega$ ,	$T_A = 25^{\circ}C$ , or +125 $^{\circ}C$		±0.2	V
	Output Voltage (Note 5)	V <sub>CC</sub> = 4.5V, Figure 1	−55°C		±0.4	V
V <sub>oc</sub>	Common Mode Output Voltage (Note 6)	$R_L = 54\Omega$ or $100\Omega$ , Figure 1			3.0	V
$\Delta  V_{OC} $	Change in Magnitude of Common	$R_L = 54\Omega$ or $100\Omega$ , $V_{CC} = 4.5V$ , Figure 1			±0.2	V
	Mode Output Voltage (Note 5)					
Io	Output Current with Power Off	$V_{CC} = 0V, V_{O} = -7.0V \text{ to}$	+12V		±50	μA
l <sub>oz</sub>	High Impedance State Output Current	$V_{\rm O} = -7.0 \text{V to } +12 \text{V}$			±50	μA
I <sub>IH</sub>	Input Current HIGH	V <sub>I</sub> = 2.4V			20	μA
I <sub>IL</sub>	Input Current LOW	V <sub>I</sub> = 0.4V			-50	μA
I <sub>os</sub>	Short Circuit Output Current	V <sub>O</sub> = -7.0V			-250	
	(Note 7)	$V_O = 0V$			-150	mA
		$V_O = V_{CC}$			150	
		V <sub>O</sub> = +12V			250	
I <sub>cc</sub>	Supply Current (All Drivers)	No Load	Outputs Enabled		50	mA
I <sub>ccx</sub>			Outputs Disabled		30	

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### MIL-STD-883C

# **Switching Characteristics**

 $V_{CC} = 5.0V$ 

Symbol	Parameter	Conditions	T <sub>A</sub> =	25°C	T <sub>A</sub> = 55°C	T <sub>A</sub> = 125°C	Units
			Тур	Max	Max	Max	
t <sub>DD</sub>	Differential Output Delay Time	$R_L = 60\Omega, C_L = 15 pF,$	15	22	30	30	ns
t <sub>TD</sub>	Differential Output Transition Time	Figure 3	15	22	40	40	ns
t <sub>PLH</sub>	Propagation Delay Time,	$R_L = 27\Omega, C_L = 15 pF,$	12	16	25	25	ns
	Low-to-High Level Output	Figure 4					
t <sub>PHL</sub>	Propagation Delay Time,		12	16	25	25	ns
	High-to-Low Level Output						
t <sub>zH</sub>	Output Enable Time to High Level	$R_L = 110\Omega$ , Figure 5	25	32	40	40	ns
t <sub>ZL</sub>	Output Enable Time to Low Level	$R_L = 110\Omega$ , Figure 6	25	35	100	100	ns
t <sub>HZ</sub>	Output Disable Time from High Level	$R_L = 110\Omega$ , Figure 5,	25	30	80	80	ns
		Note 13					
t <sub>LZ</sub>	Output Disable Time from Low Level	$R_L = 110\Omega$ , Figure 6	20	25	40	40	ns
t <sub>LZL</sub>	Output Disable Time from Low Level	Figure 6	300				ns
	with Load Resistor to GND (Note 12)						
t <sub>SKEW</sub>	Driver Output to Output	$R_L = 60\Omega$	1.0	4.0	10	10	ns

SMD Numbers: DS96F172MJ/883 5962-9076501MEA

DS96F174MJ/883 5962-9076502MEA

DS96F172ME/883 5962-9076501M2A DS96F174MW/883 5962-9076502MFA DS96F174ME/883 5962-9076502M2A

Order Number: DS96F172MJ/883, DS96F174MJ/883

NS Package Number J16A

DS96F172ME/883, DS96F174ME/883

NS Package Number E20A

DS96F172MW-MIL, DS96F174MW/883

NS Package Number W16A

For Complete Military Product Specifications, refer to the appropriate SMD or MDS.

### **Parameter Measurement Information**

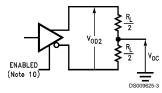


FIGURE 1. Differential and Common Mode Output Voltage

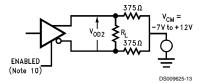
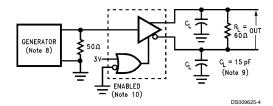


FIGURE 2. Differential Output Voltage with Varying Common Mode Voltage

### **Parameter Measurement Information (Continued)**



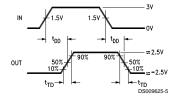
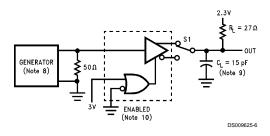


FIGURE 3. Differential Output Delay and Transition Times



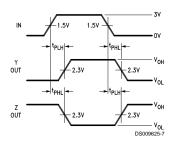
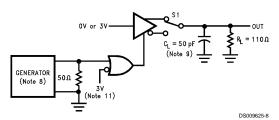


FIGURE 4. Propagation Delay Times



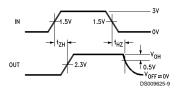
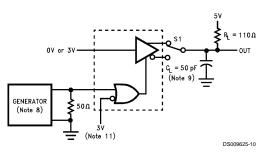


FIGURE 5.  $t_{ZH}$  and  $t_{HZ}$ 



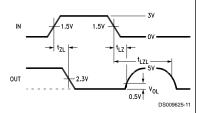


FIGURE 6.  $t_{ZL}$ ,  $t_{LZ}$ ,  $t_{LZL}$ 

Note 10: The input pulse is supplied by a generator having the following characteristics: f = 1.0 MHz, duty cycle = 50%,  $t_f \le 5.0$  ns,  $t_f \le 5.0$  ns,  $Z_Q = 50\Omega$ .

Note 11:  $C_L$  includes probe and jig capacitance.

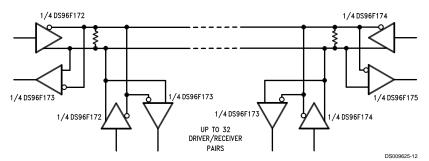
Note 12: DS96F172 with active high and active low Enables is shown. DS96F174 has active high Enable only.

Note 13: To test the active low Enable  $\overline{E}$  of DS96F172 ground E and apply an inverted waveform to  $\overline{E}$  . DS96F174 has active high Enable only.

Note 14: For more information see Application Bulletin, Contact Product Marketing.

Note 15: Not tested for DS96F172MW-MIL device.

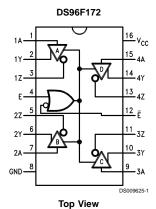
# **Typical Application**

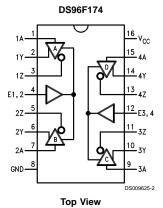


The line length should be terminated at both ends in its characteristic impedance. Stub lengths off the main line should be kept as short as possible.

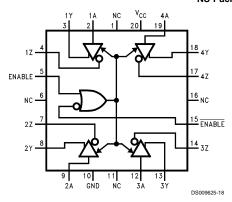
### **Connection Diagrams**

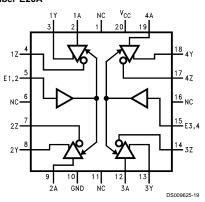
# 16-Lead Ceramic Dual-In-Line Package NS Package Number J16A





# 20-Lead Ceramic Leadless Chip Carrier NS Package Number E20A





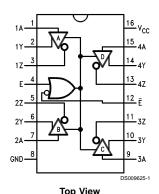
NC = No connection

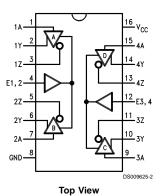
Top View

**Top View** 

# Connection Diagrams (Continued)

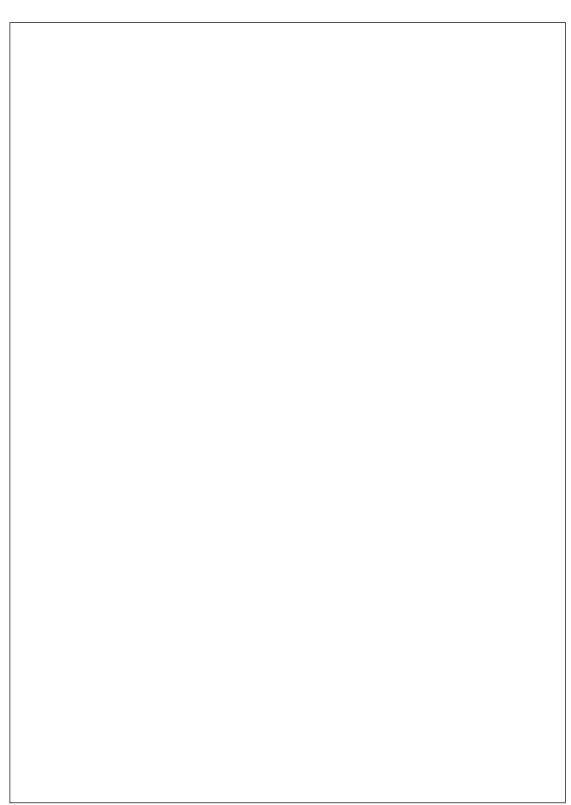
### 16-Lead Ceramic Flatpak NS Package Number W16A

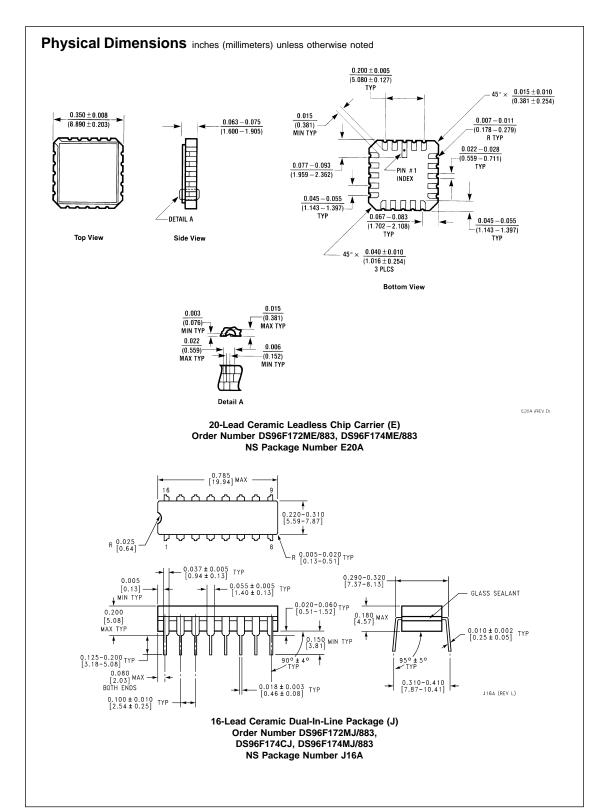




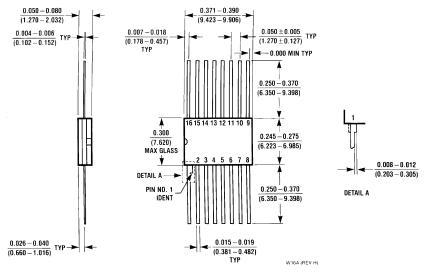
Order Numbers are located at the end of the respective Electrical Tables.

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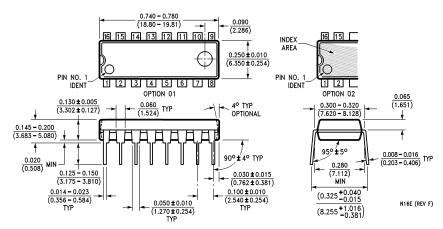




# Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



16-Lead Ceramic Flatpack (W) Order Number DS96F172MW/883, DS96F174MW/883 NS Package Number W16A



Molded Dual-In-Line Package (N)
Order Number DS96F172CN, or DS96F174CN
NS Package Number N16E

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National Semiconductor Corporation Americas

Tel: 1-800-272-9959 Fax: 1-800-737-7018 Email: support@nsc.com

www.national.com

**National Semiconductor** Europe

Fax: +49 (0) 1 80-530 85 86 Fax: +49 (0) 1 80-530 85 86 Email: europe.support@nsc.com Deutsch Tel: +49 (0) 1 80-530 85 85 English Tel: +49 (0) 1 80-532 78 32 Français Tel: +49 (0) 1 80-532 93 58 Italiano Tel: +49 (0) 1 80-534 16 80

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Fax: 65-2504466 Email: sea.support@nsc.com National Semiconductor Japan Ltd. Tel: 81-3-5620-6175 Fax: 81-3-5620-6179